

FORM JO-1449 (SUSSTITUTE)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))

Attorney	Docket	No.:

Applic. No. 09/939,330

L&L-I0078
Applicant

Alfred Kersch et al.

Filing Date

Group Art Unit

August 24, 2001

## **U.S. PATENT DOCUMENTS**

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## FOREIGN PATENT DOCUMENT

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRAI YES	
EF	J	03 197 394 A	08/28/91	Japan		:	X	
EF	К	04 137 532 A	05/12/92	Japan			X	
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## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

ÉF	0	J.L. Archer et al.: "Chemical Vapor Deposition Of Single-Crystal Metal Oxides. II. Encapsulation Of Polycrystalline Conductors In Single-Crystal Ferrite", J. Phys. Chem. Solids, Suppl. 1967, No. 1, pp. 337-340
EF	Р	Jing Zhao et al.: "Low Pressure Organometallic Chemical Vapor Deposition Of High -T <sub>C</sub> Superconducting YBa <sub>2</sub> Cu <sub>3</sub> O <sub>7-δ</sub> Films", Solid State Communications, Vol. 69, No. 2, 1989, pp. 187-189

EXAMINER

DATE CONSIDERED

12/14/02

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM PTO-109 (SUBSTEPUTE)			Attorney Docket No.: Applic. No.				<u> </u>	
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE								
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EF	Shogo Matsubara et al.: "Preparation of epitaxial ABO <sub>3</sub> perovskite-type oxide thin films on a (100)MgAl <sub>2</sub> O <sub>4</sub> /Si substrate", J. Appl. Phys. Vol. 66, No. 12, December 15, 1989, pp. 5826-5832							
EF P	Clive D. Chandler et al.: "Chemical Aspects of Solution Routes to Perovskite- Phase Mixed-Metal Oxides from Metal-Organic Precursors", Chem. Rev. 1993, No. 93, pp. 1205-1241							
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FORM PTO-1444 (SUBSTATUTE)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				Attorney Docket No.: Applic. No. L&L-10078 09/939,330  Applicant Alfred Kersch et al.  Filing Date Group Art Unit August 24, 2001				
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EF	0	D. Saulys et al.: "An examination of the surface decomposition chemistry of lithium niobate precursors under high vacuum conditions", Journal of Crystal Growth, No. 217, 2000, pp. 287-301						
EF	Р	dielectric propertie	s, and ste r depositio	cursors and substrat p coverage of (Ba,S on", Journal of Applie 2	r)TiO <sub>3</sub> films	grown by	/	ire,
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Sheet 1 of 1 PTO-1449 (SUBSTITUTE) Attorney Docket No.: Applic. No. L&L-10078 09/939.330 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE Applicant Alfred Kersch et al. INFORMATION DISCLOSURE STATEMENT BY APPLICANT Filing Date Group Art Unit (37 CFR 1.98(b)) August 24, 2001 1763 U.S. PATENT DOCUMENTS **EXAMINER** SUB FILING INITIALS PATENTEE **CLASS** CLASS DATE PATENT NO. DATE 03/21/95 Α 5,399,387 Law et al. EF EF В 5,508,067 04/16/96 Sato et al. С D Е F G 5 Н FOREIGN PATENT DOCUMENT SUB TRANSL. **CLASS** CLASS DOCUMENT NO. DATE COUNTRY YES | NO EF 0 296 891 A2 12/28/88 Europe Х Κ L М Ν OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) O Р DATE CONSIDERED **EXAMINER** EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.